

5N40-MTQ

Preliminary

5A, 400V N-CHANNEL **POWER MOSFET**

DESCRIPTION

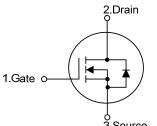
The UTC 5N40-MTQ is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology specializes in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC 5N40-MTQ is universally applied in electronic lamp ballast based on half bridge topology and high efficient switched mode power supply.

FEATURES

- $* R_{DS(ON)} < 1.6\Omega @ V_{GS} = 10V, I_D = 2.5A$
- * High switching speed
- * 100% avalanche tested

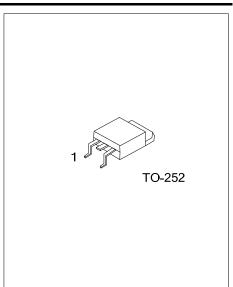
SYMBOL



3.Source

ORDERING INFORMATION

Ordering Number		Dealasas	Pin Assignment			Dealing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
5N40L-TN3-R	5N40G-TN3-R	TO-252	G	D	S	Tape Reel	
Note: Pin Assignment: G: Gate D: Drain S: Source							
5N40G-TN3-R (1)Packing Type (2)Package Type (2) TN3: TO-252							
	(3) G: Halogen Free and Lead Free, L: Lead Free						
MARKING UTC SN40 C: Lead Free G: Halogen Free Date Code 1 UTC SN40 C: Lead Free Date Code 1 UTC SN40 Difference Date Code							
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ABSOLUTE MAXIMUM RATINGS (Tc=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	400	V
Gate-Source Voltage		V _{GSS}	±30	V
Drain Current Avalanche Energy	Continuous (T _C =25°C)	I _D	5	А
	Pulsed (Note 2)	I _{DM}	10	А
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	116	mJ
Peak Diode Recovery	dv/dt (Note 4)	dv/dt	4.9	V/ns
Power Dissipation		PD	50	W
Junction Temperature		TJ	+150	°C
Storage Temperature		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=18mH, I_{AS} =3.6A, V_{DD} =50V, R_G =25 Ω , Starting T_J = 25°C

4. $I_{SD} \le 5.0A$, di/dt $\le 100A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ _{JA}	110	°C/W	
Junction to Case	θις	2.5	°C/W	

ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	400			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =400V, V _{GS} =0V			10	μA
Cate Source Lookage Current Forward	d I	V _{GS} =+30V, V _{DS} =0V			+100	nA
Gate- Source Leakage Current Revers	e I _{GSS}	V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS					-	
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$			4.0	V
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =2.5A		1.3	1.6	Ω
DYNAMIC PARAMETERS					-	
Input Capacitance	C _{ISS}			400		рF
Output Capacitance	C _{OSS}	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		56		рF
Reverse Transfer Capacitance	C _{RSS}			4.5		рF
SWITCHING PARAMETERS					-	
Total Gate Charge	Q_{G}	V _{DS} =100V, V _{GS} =10V, I _D =5.0A,		11.5		nC
Gate to Source Charge	Q_{GS}	$I_{G}=1mA$ (Note 1, 2)		4.9		nC
Gate to Drain Charge	Q_{GD}			2.3		nC
Turn-ON Delay Time	t _{D(ON)}			6		ns
Rise Time	t _R	V _{DS} =100V, V _{GS} =10V, I _D =5.0A,		16.4		ns
Turn-OFF Delay Time	t _{D(OFF)}	_R _G =25Ω (Note1,2)		24.6		ns
Fall-Time	t _F			22		ns
SOURCE- DRAIN DIODE RATINGS AN	D CHARACTERIS	TICS				
Maximum Body-Diode Continuous Curre	nt I _{SD}				5	Α
Maximum Body-Diode Pulsed Current	I _{SM}	TRE DOM			10	Α
Drain-Source Diode Forward Voltage	V _{SD}	I _S =5.0A, V _{GS} =0V			1.5	V
Reverse Recovery Time (Note 1)	trr	_ls=5.0A, V _{GS} =0V, dl⊧/dt=100A/µs		205		nS
Reverse Recovery Charge	Qrr	is=0.0Α, v _{GS} =0v, di _F /dt=100Α/μS		1.34		μC
Notes: 1. Pulse Test: Pulse width ≤ 300µ	s, Duty cycle $\leq 2\%$.	FEWINIS				_

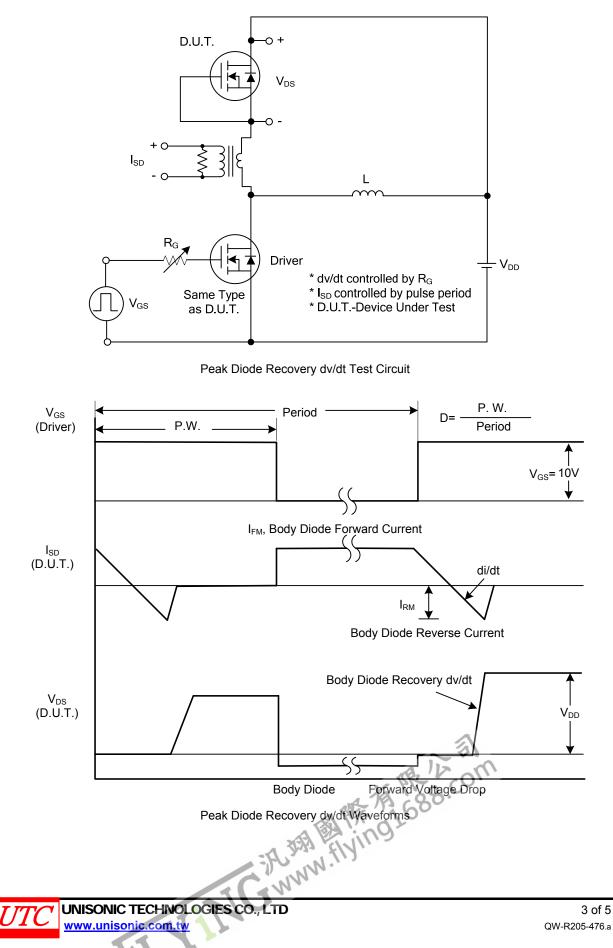
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2. Essentially independent of operating temperature. 'uise width

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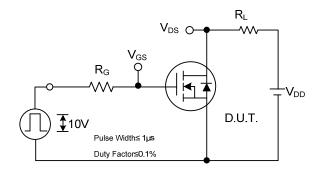
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TEST CIRCUITS AND WAVEFORMS

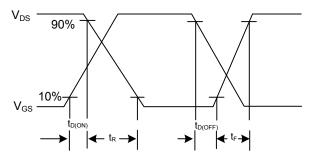


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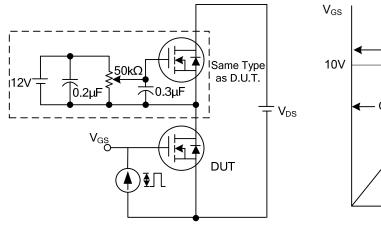
TEST CIRCUITS AND WAVEFORMS (Cont.)



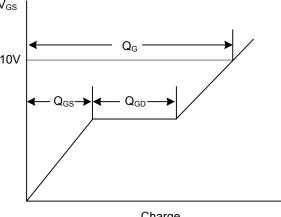




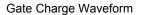
Switching Waveforms

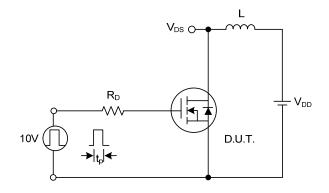


Gate Charge Test Circuit

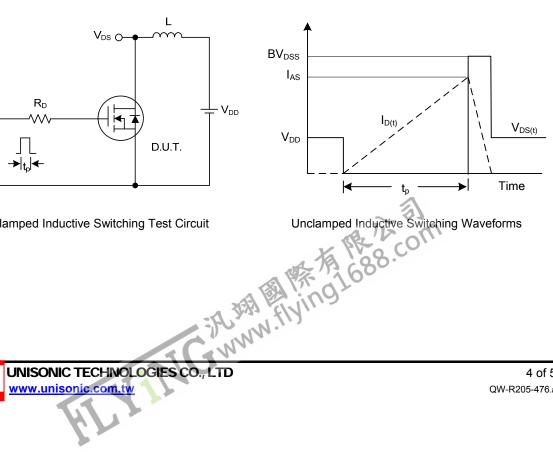


Charge





Unclamped Inductive Switching Test Circuit



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